



## RADIO TEST REPORT

Test Report No. : 28LE0042-HO-02-A

Applicant : Sony EMCS Corporation  
Type of Equipment : Digital Still Camera  
Model No. : DSC-G3  
FCC ID : AK8DSCG3  
Test regulation : FCC Part 15 Subpart C 2008  
Section 15.207, Section 15.247  
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

Date of test:

August 6 to 8, 2008

Tested by:

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NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.  
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## **SECTION 1: Customer information**

Company Name : Sony EMCS Corporation  
Brand Name : SONY  
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Contact Person : Yuuki Koyama

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment : Digital Still Camera  
Model No. : DSC-G3  
Serial No. : 0000187: used for Antenna Terminal Conducted test  
0000189: used for the other tests  
Rating : DC3.6V(Battery), DC4.2V(AC-adaptor <Input 120V/60Hz>)  
Receipt Date of Sample : August 6, 2008  
Country of Mass-production : Japan  
Condition of EUT : Engineering prototype  
(Not for Sale: This sample is equivalent to mass-produced items.)  
Modification of EUT : No modification by the test lab.

### **2.2 Product description**

Model No: DSC-G3, referred as the EUT in this report, is the Digital Still Camera.

Feature of EUT : Model No: DSC-G3 is the Digital Still Camera which incorporates Wireless LAN (IEEE802.11b/g). It can communicate with Access Point of Wireless LAN.

Clock frequency(ies) in the system : CPU1:12MHz, 27MHz, 132MHz  
CPU2:32.768kHz, 27MHz, 66MHz, 266MHz  
LCDCLK:27MHz, CAM\_Motor\_CPU:27MHz  
CAM HCLK:38MHz/19MHz, USB(HSmode):240MHz  
USB(FSmode):6MHz, MemoryStick(Pro\_mode):38.4MHz  
MemoryStick(NegotiationOnly):19.2MHz  
WLAN:38.4MHz, 2.4GHz, 16MHz, NANDCLK:44MHz

#### **[Radio part]**

Equipment Type : Transceiver  
Frequency of Operation : 2412-2462MHz  
Bandwidth & Channel Spacing : 20MHz & 5MHz  
Type of modulation : DSSS, OFDM  
Antenna Type : Chip Antenna  
Antenna Connector Type : HSC(murata)  
Antenna Gain : -5dBi  
Method of Frequency Generation : Crystal, Synthesizer  
Operating temperature range : 0-40deg. C  
Operating voltage (Inner) : DC2.9V & DC1.8V (internal WLAN)

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### **SECTION 3: Test specification, procedures & results**

#### **3.1 Test Specification**

Test Specification : FCC Part15 Subpart C: 2008, final revised on May 19, 2008

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.207 Conducted limits  
Section 15.247 Operation within the bands 902-928MHz,  
2400-2483.5MHz, and 5725-5850MHz

#### **FCC 15.31 (e)**

This EUT provides stable voltage(DC2.9V&DC1.8V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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### 3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements ----- IC: RSS-Gen 7.2.2	FCC: Section 15.207 ----- IC: RSS-Gen 7.2.2	Conducted	N/A	[QP] 15.8dB 0.20515MHz, L, 11b, Ch: Low [AV] 11.5dB 0.20477MHz, N, 11b, Ch: Low	Complied
2	6dB Bandwidth	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) ----- IC: RSS-210 A8.2(a)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) ----- IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: -	FCC: Section 15.247 (d) ----- IC: RSS-210 A8.5	Conducted/ Radiated	N/A		Complied
5	Power Density	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: -	FCC: Section 15.247 (e) ----- IC: RSS-210 A8.2(b)	Conducted	N/A		Complied
6	Spurious Emission	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" ----- IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d) ----- IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted/ Radiated	N/A	[Tx] 4.1dB 666.334MHz, Vert, 11b, Ch: Low [Rx] 5.4dB 664.470MHz, Vert, 11b/g, Ch: Mid	Complied

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

\*These tests were performed without any deviations from test procedure except for additions or exclusions.

\* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

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### 3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission	Radiated emission (10m*)				Radiated emission (3m*)			Radiated emission (3m*)	
	150kHz-30MHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	1GHz-18GHz	18GHz-40GHz	
No.1 semi-anechoic chamber (±)	3.7dB	3.1dB	4.4dB	4.2dB	3.2dB	3.8dB	3.9dB	5.9dB	6.1dB	
No.2 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.4dB	4.0dB	5.9dB	6.1dB	
No.3 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	4.6dB	4.0dB	5.9dB	6.1dB	
No.4 semi-anechoic chamber (±)	3.7dB	-	-	-	3.2dB	3.9dB	3.9dB	5.9dB	6.1dB	

\*10m/3m = Measurement distance

#### Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

#### Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

#### Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is 3.0dB.

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### 3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

**SECTION 4: Operation of E.U.T. during testing**

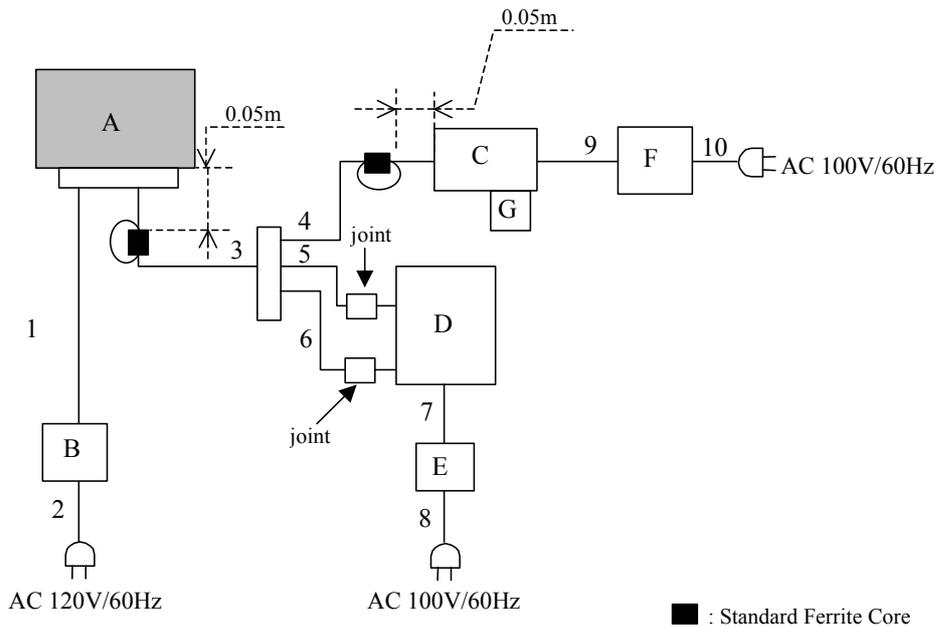
**4.1 Operating Mode(s)**

Test Item	Operating Mode	Tested frequency
Conducted emission Spurious Emission	IEEE802.11b Transmitting (Tx), 11Mbps, PN	2412MHz(L)
	IEEE802.11g Transmitting (Tx), 54Mbps, PN	2437MHz(M) 2462MHz(H)
	IEEE802.11b/g Receiving (Rx)	2437MHz(M)
6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	IEEE802.11b Transmitting (Tx), 11Mbps, PN	2412MHz(L)
	IEEE802.11g Transmitting (Tx), 54Mbps, PN	2437MHz(M) 2462MHz(H)
Restricted Band Edge	IEEE802.11b Transmitting (Tx), 11Mbps, PN IEEE802.11g Transmitting (Tx), 54Mbps, PN	2412MHz(L) 2462MHz(H)

\*Transmitting duty was 100% on all tests.

\*As a result of preliminary test, the formal test was performed with the above modes, which had the maximum rated power.

**4.2 Configuration and peripherals**



\* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

**Description of EUT and Support equipment**

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Digital Still Camera	DSC-G3	0000187 *1) 0000189 *2)	Sony EMCS Corporation	EUT
B	AC Adaptor	AC-LS5	56816905	SONY	-
C	Note PC	PCG-6V2N	2827 0610 1000746	SONY	-
D	HANDY CAM	DCR-HC90	35391	SONY	-
E	AC Adaptor	AC-L200B	07085504927	SONY	-
F	AC Adaptor	VGP-AC19V25	148013121 0082704	SONY	-
G	HASP Key	SEUS	00005104	SONY	-

\*1) Used for Antenna terminal conducted tests

\*2) Used for the other tests

**List of cables used**

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	DC cable	1.85	Unshielded	Unshielded	-
2	AC cable	2.0	Unshielded	Unshielded	-
3	AV / Audio / USB cable	1.25	Shielded	Shielded	One Ferrite Core (model: ZCAT2035-0930, manufacturer: TDK, Two turns) *1)
4	USB cable	0.18	Shielded	Shielded	One Ferrite Core (model: ZCAT13250530, manufacturer: TDK, Two turns) *1)
5	AV cable	1.8	Shielded	Shielded	-
6	Audio cable	1.8	Shielded	Shielded	-
7	DC cable	1.6	Unshielded	Unshielded	-
8	AC cable	2.0	Unshielded	Unshielded	-
9	DC cable	1.8	Unshielded	Unshielded	-
10	AC cable	1.0	Unshielded	Unshielded	-

\*1) This core is attached to the final marketing products.

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## **SECTION 5: Conducted Emission**

### **Test Procedure and conditions**

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

#### **For the tests on EUT with other peripherals (as a whole system)**

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

**Detector** : quasi-peak and average detector (IF BW 9 kHz)  
**Measurement range** : 0.15-30MHz  
**Test data** : APPENDIX 2  
**Test result** : Pass

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## **SECTION 6: Spurious Emission**

### **[Conducted]**

#### **Test Procedure**

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.

It was measured based on "1. RF antenna conducted test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

The following spectrum analyzer setting was used:

- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data : APPENDIX 2**

**Test result : Pass**

### **[Radiated]**

#### **Test Procedure**

It was measured based on "2. Radiated emission test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 80cm above the conducting ground plane.

The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

The result also satisfied with the general limits specified in section FCC 15.209(a) / RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver	Spectrum Analyzer
Detector	QP: BW 120kHz	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth		AV: RBW:1MHz/VBW:10Hz

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

**Test data : APPENDIX 2**

**Test result : Pass**

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## **SECTION 7: Bandwidth**

### **6dB Bandwidth**

#### **Test Procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.  
It was measured based on "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247 ".  
The following spectrum analyzer setting was used:

- Span: 50MHz
- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

### **99% Occupied Bandwidth**

#### **Test Procedure**

The bandwidth was measured with a spectrum analyzer connected to the antenna port.  
The following spectrum analyzer setting was used:

- Span: Enough width to display 20dB Bandwidth
- RBW: as close to 1% of the Span as is possible without being below 1%
- VBW: Three times of RBW
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 8: Maximum Peak Output Power**

### **Test Procedure**

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.

It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

**Test data** : APPENDIX 2  
**Test result** : Pass

## **SECTION 9: Peak Power Density**

**[Conducted]**

### **Test Procedure**

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.

It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

- Span: 1.5MHz
- RBW: 3kHz
- VBW: 100kHz
- Sweep: 500sec
- Detector: Peak
- Trace: Max Hold

**Test data** : APPENDIX 2  
**Test result** : Pass

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